

SQS401EN-T1-GE3-VB Datasheet P-Channel 40 V (D-S) MOSFET

PRODUCT SUMMARY						
V _{DS} (V)	$R_{DS(on)}(\Omega)$	I _D (A)	Q _g (Typ.)			
- 40	$0.012 \text{ at V}_{GS} = -10 \text{ V}$	- 45 ^d	43.1 nC			
- 40	0.013 at $V_{GS} = -4.5$ V	- 40 ^d	43.1110			

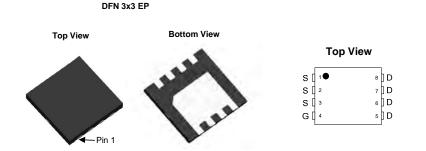
FEATURES

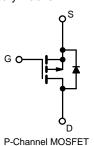
- Trench Power MOSFET
- · Low On-Resistance for Low Voltage Drop
- 100 % R_g and UIS Tested

ROHS COMPLIANT HALOGEN FREE

APPLICATIONS

- · Battery, Load and Adaptor Switches
 - Notebook Computers
 - Notebook Battery Packs





ABSOLUTE MAXIMUM RATINGS (T _A = 25 °C, unless otherwise noted)						
Parameter	Symbol	Limit	Unit			
Drain-Source Voltage	V_{DS}	- 40	V			
Gate-Source Voltage		V_{GS}	± 20	V		
	T _C = 25 °C		- 45 ^d			
Continuous Drain Current (T _{.1} = 150 °C)	T _C = 70 °C	1_	- 40 ^d			
Continuous Diam Curient (1) = 130 °C)	T _A = 25 °C	- I _D	- 33.1 ^{a, b}			
	T _A = 70 °C	1	- 28.4 ^{a, b}	A		
Pulsed Drain Current (t = 100 μs)		I _{DM}	- 100			
Continuous Source-Drain Diode Current	T _C = 25 °C	1.	- 50 ^d			
Continuous Source-Diam Diode Current	T _A = 25 °C	I _S	- 4.1 ^{a, b}			
Avalanche Current	L = 0.1 mH	I _{AS}	- 25			
Single-Pulse Avalanche Energy	L = 0.1 IIII	E _{AS}	31.2	mJ		
	T _C = 25 °C		48			
Maximum Power Dissipation	T _C = 70 °C	P _D	31	w		
Maximum Power Dissipation	T _A = 25 °C] '	5 ^{a, b}			
	T _A = 70 °C	1	3.2 ^{a, b}			
Operating Junction and Storage Temperature Range	T _J , T _{stg}	- 55 to 150	°C			
Soldering Recommendations (Peak Temperature) ^{e, f}		260	7			

THERMAL RESISTANCE RATINGS					
Parameter		Symbol	Typical	Maximum	Unit
Maximum Junction-to-Ambient ^{a, c}	t ≤ 10 s	R _{thJA}	21	25	°C/W
Maximum Junction-to-Case	Steady State	R _{thJC}	2.1	2.6	C/VV

Notes:

- a. Surface mounted on 1" x 1" FR4 board.
- b. t = 10 s.
- c. Maximum under steady state conditions is 70 °C/W.
- d. Package limited.
- e. The DFN3X3 is a leadless package. The end of the lead terminal is exposed copper (not plated) as a result of the singulation process in manufacturing. A solder fillet at the exposed copper tip cannot be guaranteed and is not required to ensure adequate bottom side solder interconnection.
- f. Rework conditions: manual soldering with a soldering iron is not recommended for leadless components.



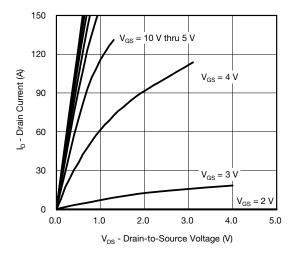
SPECIFICATIONS ($T_J = 25$ °C) Parameter	Symbol	Test Conditions	Min.	Тур.	Max.	Unit	
Static	Cyllibol	rest conditions		Typ.	WIGA.	Oilit	
Drain-Source Breakdown Voltage	V _{DS}	V _{GS} = 0, I _D = - 250 μA	- 40			V	
V _{DS} Temperature Coefficient	ΔV _{DS} /T _J	VGS = 0, 1 _D = 200 μ/τ		- 22		+ -	
V _{GS(th)} Temperature Coefficient	$\Delta V_{GS(th)}/T_J$	I _D = - 250 μA		4.1		mV/°C	
()	` '	$V_{DS} = V_{GS}, I_{D} = -250 \mu A$	4.0	4.1	0.5	V	
Gate-Source Threshold Voltage	V _{GS(th)}		- 1.2		- 2.5	·	
Gate-Source Leakage	I _{GSS}	V _{DS} = 0 V, V _{GS} = ± 20 V			± 100	nA	
Zero Gate Voltage Drain Current	I _{DSS}	V _{DS} = - 30 V, V _{GS} = 0 V			- 1	μΑ	
Zoro Gato Voltago Ziam Gamem	.088	V _{DS} = - 30 V, V _{GS} = 0 V, T _J = 55 °C	- 5		- 5	Π μ/ (
On-State Drain Current ^a	I _{D(on)}	$V_{DS} \ge -10 \text{ V}, V_{GS} = -10 \text{ V}$	- 30			Α	
	Б	V _{GS} = - 10 V, I _D = - 15 A	0.012			Ω	
Drain-Source On-State Resistance ^a	R _{DS(on)}	V _{GS} = - 4.5 V, I _D = - 10 A		0.013			
Forward Transconductance ^a	9 _{fs}	V _{DS} = - 10 V, I _D = - 15 A		60		S	
Dynamic ^b			L	L	1		
Input Capacitance	C _{iss}			5125			
Output Capacitance	C _{oss}	V _{DS} = - 15 V, V _{GS} = 0 V, f = 1 MHz		615		pF	
Reverse Transfer Capacitance	C _{rss}			554		-	
Treverse Hansier Supusitation	Orss	V _{DS} = - 15 V, V _{GS} = - 10 V, I _D = - 10 A		90 135	135		
Total Gate Charge	Q _g Q _{gs}	V _{DS} = 10 V, V _{GS} = 10 V, I _D = 10 Y		43.1	65	nC	
Gate-Source Charge		V _{DS} = - 15 V, V _{GS} = - 4.5 V, I _D = - 10 A		13.6	03		
		V _{DS} = - 13 v, v _{GS} = - 4.3 v, I _D = - 10 A		28.8			
Gate-Drain Charge	Q _{gd}	(() ()	0.5		4.0		
Gate Resistance	R _g	f = 1 MHz	0.5	2.4	4.8	Ω	
Turn-On Delay Time	t _{d(on)}			15	30		
Rise Time	t _r	$V_{DD} = -15 \text{ V}, R_{L} = 1.5 \Omega$		12	24		
Turn-Off DelayTime	t _{d(off)}	$I_D \cong$ - 10 A, V_{GEN} = - 10 V, R_g = 1 Ω		58	110		
Fall Time	t _f			12	24	ns	
Turn-On Delay Time	t _{d(on)}			60	120	115	
Rise Time	t _r	$V_{DD} = -15 \text{ V}, R_{L} = 1.5 \Omega$		60	120		
Turn-Off DelayTime	t _{d(off)}	$I_D \cong -10 \text{ A}, V_{GEN} = -4.5 \text{ V}, R_g = 1 \Omega$		52	100	-	
Fall Time	t _f	1		26	52		
Drain-Source Body Diode Characteris	tics		l	1	1		
Continous Source-Drain Diode Current	I _S	T _C = 25 °C			- 50		
Pulse Diode Forward Current (100 μs)	I _{SM}				- 100	- A	
Body Diode Voltage	V_{SD}	I _S = - 3 A, V _{GS} = 0		- 0.74	- 1.20	V	
Body Diode Reverse Recovery Time	t _{rr}	- 55		23	46	ns	
Body Diode Reverse Recovery Charge	Q _{rr}	I _F = - 10 A, dl/dt = 100 A/μs, T _J = 25 °C		12	24	nC	
Reverse Recovery Fall Time	t _a	$\begin{bmatrix} 1 & 1 & 1 & 1 & 1 & 1 & 1 & 1 & 1 & 1 $		9		ns	
Reverse Recovery Rise Time	t _b	t _b		14			

Notes:

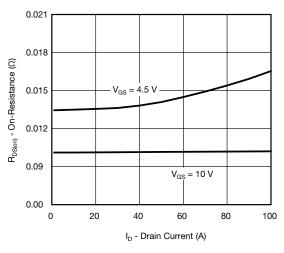
- a. Pulse test; pulse width $\leq 300~\mu s,$ duty cycle $\leq 2~\%.$
- b. Guaranteed by design, not subject to production testing.

Stresses beyond those listed under "Absolute Maximum Ratings" may cause permanent damage to the device. These are stress ratings only, and functional operation of the device at these or any other conditions beyond those indicated in the operational sections of the specifications is not implied. Exposure to absolute maximum rating conditions for extended periods may affect device reliability.

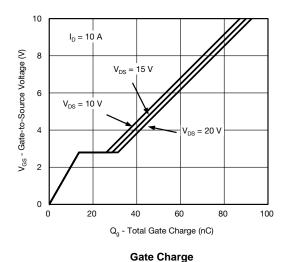


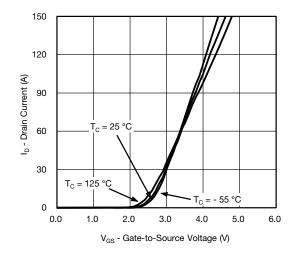


Output Characteristics

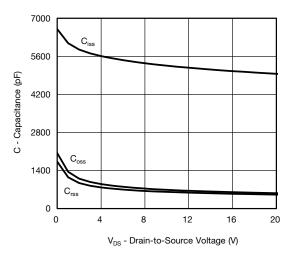


On-Resistance vs. Drain Current

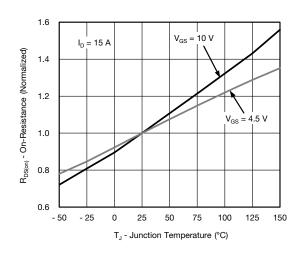




Transfer Characteristics

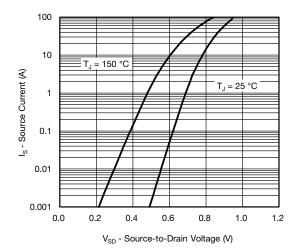


Capacitance

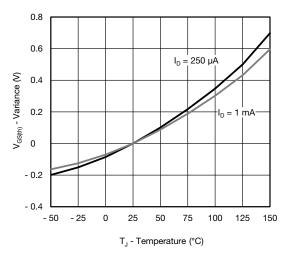


On-Resistance vs. Junction Temperature

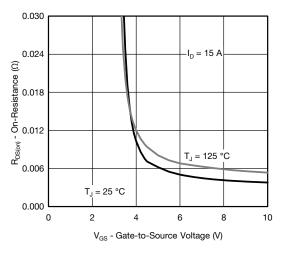




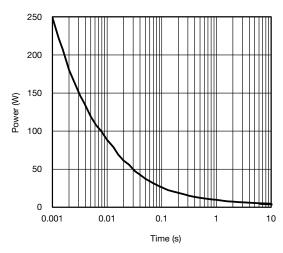
Source-Drain Diode Forward Voltage



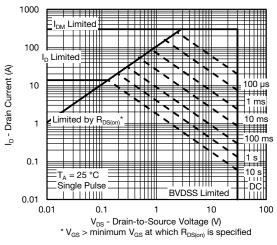
Threshold Voltage



On-Resistance vs. Gate-to-Source Voltage

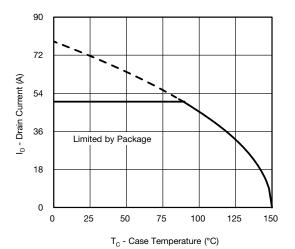


Single Pulse Power, Junction-to-Ambient

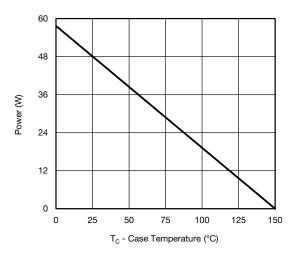


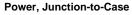
Safe Operating Area

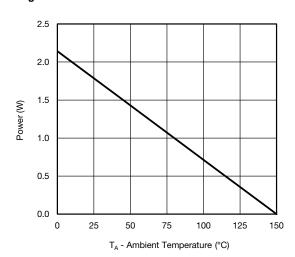




Current Derating*





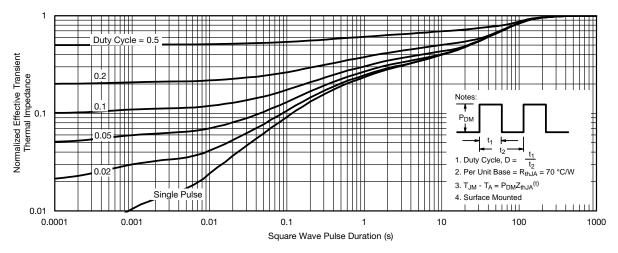


Power Derating, Junction-to-Ambient

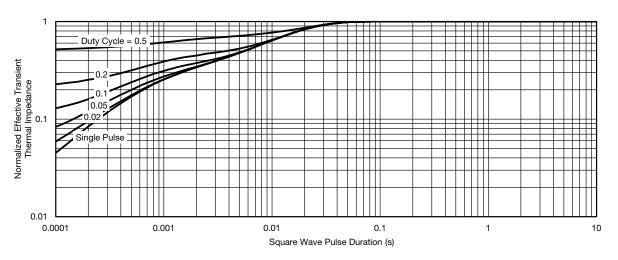
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^{*} The power dissipation P_D is based on $T_{J(max.)}$ = 150 °C, using junction-to-case thermal resistance, and is more useful in settling the upper dissipation limit for cases where additional heatsinking is used. It is used to determine the current rating, when this rating falls below the package limit.



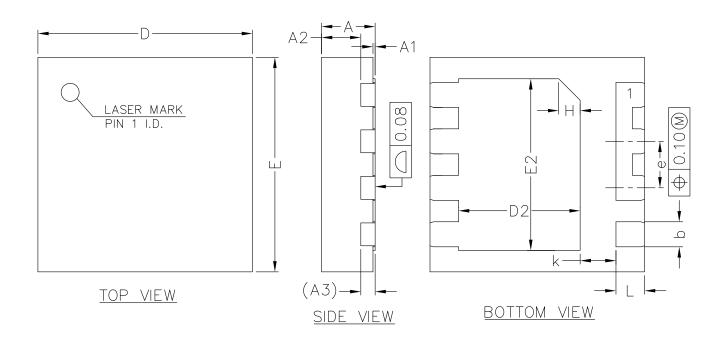


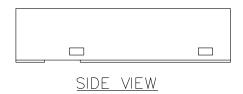
Normalized Thermal Transient Impedance, Junction-to-Ambient



Normalized Thermal Transient Impedance, Junction-to-Case







COMMON DIMENSIONS (UNITS OF MEASURE=MILLIMETER)

SYMBOL	MIN	NOM	MAX
Α	0.70	0.75	0.80
A1	0.00	0.02	0.05
A2	0.50	0.55	0.60
А3		0.20REF	
Ь	0.30	0.35	0.40
D	2.90	3.00	3.10
Ε	2.90	3.00	3.10
D2	1.60	1.70	1.80
E2	2.30	2.40	2.50
е	0.55	0.65	0.75
K	0.40	0.50	0.60
L	0.35	0.40	0.45



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